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Applicant(s)/Patent under Reexamination
CHO, CHANG-YUL

10/522,379

Art Unit

Examiner

Andrew W. Sutton

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	SEARCHED			
Class	Subclass	Date	Examiner	
223	78-79	6/25/2006	AWS	
623	57/65			

INT	INTERFERENCE SEARCHED				
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SEARCH (INCLUDING SEAR	NOTES CH STRATEGY	")
	DATE	EXMR
East Search (Attached)	6/25/2006	AWS